Notic of R ferences Cited Application/Control No. 10/717,955 Applicant(s)/Patent Under Reexamination VU, HA C. Examiner Hai L. Nguyen Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| _ | Α | US-6,603,360 | 08-2003 | Kim et al. | 331/16 |
| | В | US-6,559,726 | 05-2003 | Stansell, Galen E. | 331/16 |
| | С | US-6,385,276 | 05-2002 | Hunt et al. | 377/47 |
| | D | US-6,163,181 | 12-2000 | Nishiyama, Selichi | 377/47 |
| | E | US-6,097,782 | 08-2000 | Foroudi, Navid | 377/47 |
| | F | US-5,867,068 | 02-1999 | Keating, Pierce V. | 377/48 |
| | G | US-5,859,890 | 01-1999 | Shurboff et al. | 377/48 |
| | Н | US-5,841,302 | 11-1998 | Ishii et al. | 327/117 |
| | 1 | US-5,202,906 | 04-1993 | Saito et al. | 331/14 |
| | J | US-5,084,907 | 01-1992 | Maemura, Kosei | 377/48 |
| | к | US-4,991,187 | 02-1991 | Herold et al. | 377/48 |
| | L | US-4,575,867 | 03-1986 | Hogue, Noel E. | 377/110 |
| | М | US-4,325,031 | 04-1982 | Ooms et al. | 331/1A |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | ď | | | | | |
| | R | | | | | |
| | S | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | w | |
| | х | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.